Threshold plasticity of hybrid Si-VO₂ microring resonators

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Abstract: We theoretically simulate the threshold plasticity of a high-Q-factor silicon-on-insulator microring resonator integrated with VO₂. The proposed structure can perform excitatory and inhibitory learning by tuning the initial working condition. © 2020 The Author(s) **OCIS codes:** 200.4700 Optical neural systems; 230.1150 All-optical devices; 230.3120 Integrated optics devices.

1. Introduction

Silicon-on-insulator (SOI) microring resonators are small-size passive devices and can be integrated on-chip. The high-Q SOI-microring resonator can exhibit class II neural excitability if it is pumped by sufficiently high input powers with a wavelength close to the resonance of the cavity [1, 2]. Threshold plasticity [3], which means the neural system learns by changing threshold rather than weights, is a candidate for learning of spiking neurons, and it is simpler and more amenable to hardware implementation. VO₂ is a phase change material that exhibits reversible semiconductor-to-metal transition (SMT). The SMT in VO₂ results in a large change in near-infrared transmission and refractive index, and it can be triggered by many different stimuli, such as temperature, electric field and optical excitation [4]. Hysteresis is a very important phase transition property for VO₂, and broad hysteresis could be useful in optical memory devices [5, 6].

In this paper, we propose to implement the threshold plasticity of nonlinear microring resonators by depositing a thin VO_2 film on top, as shown in Fig. 1(a). The simulations illustrating the concepts of this paper are performed with the nonlinear circuit simulator Caphe [7]. We demonstrate that our architecture can realize excitatory and inhibitory learning behavior.

2. Nonlinear microring resonator with VO₂

The excitable microring is based on the cooperative effects of free-carrier dispersion (FCD) and the thermo-optic (TO) effect which induce a blueshift and redshift of the resonance wavelength, respectively. The coupled mode theory (CMT) model of a microring can correctly describe a wide range of nonlinear dynamics [1]. By integrating VO_2 on top of the ring, the SMT can be harnessed to introduce a significant change in absorption and effective index. The frequency shift induced by TO, FCD, two-photon absorption (TPA) effect and SMT is

$$\delta \omega_{nl} = -\frac{\omega_r}{n_g} \left[\frac{\mathrm{d}n_{si}}{\mathrm{d}T} \Delta T + \frac{\mathrm{d}n_{si}}{\mathrm{d}N} N + \frac{cn_2 \Gamma_{TPA} \left|a\right|^2}{n_g V_{TPA}} + \frac{dn_{SMT}}{\mathrm{d}T} \zeta \Delta T \right],\tag{1}$$

where ω_r is the resonance frequency of the cavity, n_{Si} is the refractive index of bulk silicon, *a* is the mode amplitude, ΔT is the mode-averaged temperature difference with the surroundings, *N* is the concentration of free carriers, dn_{β}/dT is effective index change coefficient by nonlinear effect β , *c* is the speed of light in vacuum, Γ_{TPA} is the TPA confinement factor, V_{TPA} is the TPA effective volume, n_2 is the Kerr nonlinear index, *L* is the length of VO₂, $\zeta = L/(2\pi R)$ is the ratio of VO₂ length to microring circumference, $n_g = (1 - \zeta)n_{Si} + \zeta n_{SMT}(T_0)$ is the average group index of microring, and T_0 is the initial temperature. The loss rate induced by SMT is $\gamma_{SMT} = \zeta \alpha c / n_g$ [8], and *a* is the loss of Si-VO₂ waveguide. We assume that the linear absorption loss fraction induced by VO₂ is $\eta_{SMT,lin} = 0.4$. The parameters of VO₂ using in our simulation are extracted from Ref. [9]. The thickness of VO₂ on top of the microring is 80nm. When VO₂ is in the fully insulating phase (30°C), the designed Si-VO₂ waveguide supports a TE-mode with effective index of $n_{eff}=2.691$ and propagation loss of $\alpha=2.98$ dB/um, as shown in Fig.1 (b); when VO₂ is fully in the metallic state (85°C), the designed Si-VO₂ waveguide supports a TE-mode with effective index of $\alpha=3.49$ dB/um, as shown in Fig.1 (c). Th2A.26.pdf



Fig. 1. (a) Schematic diagram of microring integrated with VO₂; the simulated electric field intensity of the Si-VO₂ waveguide when the VO₂ is in the (b) insulating and (c) metallic state

The hysteresis of VO₂ can be described by Prandtl-Ishlinskii (PI) model [10]. In this paper, we define a PI model of VO₂ and give a state-of-the art overview of the dynamic analysis of ring integrated with VO₂. As shown in Fig. 2 (a) and (b), by starting with the fully insulating state (20°C), we heat up VO₂ to various temperatures then cool back to the insulating state. The cooling and heating processes take different paths which are found in many measurements [5, 6, 11]. Therefore, the information is stored in the phase transition of VO₂, which means it can be used as a memory material.



Fig. 2. The hysteresis of (a) effective index and (b) loss change of Si-VO₂ waveguide describing by temperature

The effective index and loss of Si-VO₂ waveguide highly depend on the initial temperature T_0 , as shown in Fig. 2. The effective index exhibits a monotonous change with the temperature; the loss increases first then decreases while temperature increases. As shown in Fig. 3 (a) and (b), when T_0 is changed from 54°C to 66°C, the threshold of the microring increases with increasing temperature; when T_0 is changed from 70°C to 82°C, the threshold decreases with increasing temperature. This corresponds to the change of loss of Si-VO₂ waveguide shown in Fig. 2(b).



Fig. 3. Threshold of optical spiking ring changes with different power of pump light at different initial temperature T_0 . $\Delta\lambda$ =100pm, t_{tt} =10ns, ζ =0.0004.

By sending pulses with varying P_{tr} -height (amplitude of trigger pulse), we can get the threshold change of microring, as shown in Fig. 4. The trigger pulses are square pulses with 10ns width, the wavelength of trigger light is the same as the pump light with wavelength detuning $\Delta\lambda$ =100pm, and the range of the initial temperature T_0 is from 54°C to 82°C. When T_0 is changed from 54°C to 62°C, the threshold of microring increases with the increasing P_{tr} due to the increasing loss induced by the SMT, as shown in Fig. 4(a)-(c). When the ring works at 66°C, with the increasing amplitude of trigger light, the threshold of microring increases at first then decreases, as shown in Fig. 4(d). This is because the loss induced by the SMT increases first then decreases. When T_0 is changed from 70°C to 82°C, the threshold decreases with the increasing amplitude of trigger light, the increasing amplitude of trigger light solution to the solution of the so

in Fig. 4(e)-(h).



Fig.4. Threshold of optical spiking ring changes different amplitude of trigger pulse P_{tr} at different initial temperature T_0 . $P_{in}=2$ mW, $\zeta=0.0004$, $\Delta\lambda=100$ pm, $t_{tr}=10$ ns

3. Conclusion

In conclusion, we numerically simulate the threshold plasticity of a high-Q microring integrated with VO₂. The proposed architecture can perform excitatory and inhibitory learning behavior by tuning the initial temperature, as well as electrical bias.

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5. References

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